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PERICOM[®] Saronix-ecera[®] PSE Technology Corporation

SPECIFICATION FOR APPROVAL

CUSTOMER

NOMINAL FREQUENCY

PRODUCT TYPE

SPEC. NO. (P/N)

CUSTOMER P/N

ISSUE DATE

VERSION

32.768 KHz

TYPE G8 SMD CRYSTAL

G83270023

Jun.16,2016

А

 APPROVED
 PREPARED
 QA

 Brenda
 Clane
 Somy Jay

 APPROVED BY CUSTOMER :
 AVL Status

 Please return one copy with approval to PSE-TW

 PSE Technology Corporation

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*RoHS Compliant

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G83270023

VER. A 16-Jun-16

VERSION HISTORY

Version No.	Version Date	Customer Receipt Date	Supplier Receipt Date	Description	Notes
А	Jun.16,2016			Initial Release	



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ELECTRICAL SPECIFICATIONS

SRe Part Number : G83270023

Parameters	Symbol	Specifications	Units	Notes
Nominal Frequency	Fn	32.768	KHz	
Frequency Tolerance	FT	± 20	ppm	at 25°C ± 5°C
Load Capacitance	CL	7	pF	Тур.
Drive Level	DL	0.1 / 0.5	μW	Typ. / Max.
Equivalent Series Resistance	ESR	70	ΚΩ	Max.
Temperature Coefficient	К	-0.03	ppm/°C ²	± 0.01ppm/°C ²
Operating Temperature Range	TR	-40 to 85	°C	
Shunt Capacitance	C0	1.5	pF	Тур.
Motional Capacitance	C1	6.5	fF	Тур.
Quality Factor	Q	13	К	Min.
Aging		± 3	ppm	Max. 1st year
Storage Temperature Range		-40 to 85	°C	
Insulation Resistance		500	MΩ	Min.

Reliability (Mechanical and environmental performances)

No.	Test Items	Conditions	Requirements	
1	Bending test	Apply pressure in the direction of the arrow at a rate of about 0.5mm/s until bent width reaches 5mm, and hold for 30 seconds.	 Without mechanical damage such as breaks and satisfy sealing specification. Frequency change: Within ±5ppm 	
2	Shear test	Apply 20N(2.04kgf) static load to the core of quartz crystal units in the direction of the arrow using a R0.5 scratch tool, then hold for 5 seconds.	 Equivalent series resistance(E.S.R) change: Within 5kΩ 	
3	Core body strength	Apply 10N(1.02kgf) static load to the quartz crystal units center in the direction of the arrow using a R0.5 pushing tool, then hold for 10 seconds.		
4	Vibration	Frequency sweep method shall be applied as follows. Quartz crystal units shall be vibrated with the sweeping frequency from 10Hz to 55Hz and return to 10Hz in 1 minute, with 1.5mm amplitude. This vibration shall be applied for 2 hours in each 3 perpendicular axes. Other procedures conform to JIS C 60068-2-6.		
5	Shock	Quartz crystal units shall be accelerated at 9810m/s2 by 1ms pulse duration. This shock shall be applied 3 times in each 3 perpendicular axes. Other procedures conform to JIS C 60068-2-27.		

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6	Cold	Quartz crystal units shall be stored in the -40 \pm 3 $^{\circ}$ C atmosphere for 1000 hours. Other procedures conform to JIS C 60068-2-1.			 Frequency change: Within ±5ppm Equivalent series resistance(E.S.R) change: Within 5kΩ
7	Dry heat	Quartz crystal units shall be stored in the 100±2°C atmosphere for 100 hours. Other procedures conform to JIS C 60068-2-2.			After conditioning, quartz crystal units n to shall be subjected to standard atmospheric conditions for 1 hour, and measured.
8	Damp heat	Quartz crystal units shall be stored in the $40\pm2^{\circ}$ C atmosphere with 90 to 95% relative humidity for 1000 hours. Other procedures conform to JIS C 60068-2-3.			
9 Change of temperature		Quartz crystal units shall be subjected successively 100 cycles of temperature change shown below. Other procedures conform to JIS C 0025.			100
		1 2 3 4	Temperate -40±3 °C Normal temper 100±2 °C Normal temper	30min. rature Within 30 sec. 30min.	
10	Sealing	Both the test methods specified below shall be applied.			ed.
		Quartz cr		be soaked in 90 $^\circ\!\mathbb{C}$ or higher	
			etric leakage de	be tested by Mass tector to measure the leaka	• 1×10-9 Pa·m3/s or less
11	Aging	Quartz crystal units shall be stored in the $85\pm3^\circ\mathbb{C}$			Frequency change: Within ±5ppm
		atmosphe	ere for 720±12 h	ours.	 Equivalent series resistance(E.S.R) change: Within 5kΩ
					• After conditioning, quartz crystal units shall be subjected to standard atmospheric conditions for 1 hour, and measured.
12	Solder-ability Terminals coated with flux shall be immersed in the solder bath for 3.5±0.5 seconds.		• Minimum 95% of immersed terminal shall be covered with new uniform solder.		
			Items	Conditions	
			Solder	Sn-3.0Ag-0.5Cu	
		1			
		2	Flux	Approximately 25wt% methanol(JIS K 8891) solution of resin(JIS K 5902).	



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13	Resistance to	Reflow soldering method				
	soldering heat	Temperature profile				
		Soldering 220 - Soldering 220 - Slow cooling(Stored at room temperature)				
		$90\pm10s$ Within 5sPeak temperature: $260\pm5^{\circ}C$ for within 5seconds. Soldering temperature: $220^{\circ}C$ or higher for 60 ± 10 seconds.• Frequency change: Within $\pm5ppm$ • Equivalent series resistance (E.S.R) change: Within $10k\Omega$ • After conditioning, quartz crystal units shall be subjected to standard atmospheric conditions for 1 hour, and measured.Within 5sPre-heating temperature: $160\pm10^{\circ}C$ for 90 ± 10 seconds. Quartz crystal units which is put on PCB shall be through reflow soldering furnace twice with the condition 				
		Apply hot air for 7±0.5seconds, distance 10mm, 300±5° • Equivalent series resistance(E.S.R) C, flow 10L/minutes • After conditioning, quartz crystal units shall be subjected to standard atmospheric conditions for 1 hour, and measured.				
		Without distinct deformation in appearance.				
14	Solubility to resistance	Soak cleaning Quartz crystal units shall be soaked in isopropyl alcohol at normal temperature for 90 seconds.• Without mechanical damage such as breaks and satisfy sealing specification. • Frequency change: Within ±5ppm • Equivalent series resistance(E.S.R) change: Within 5kΩ				
		Without distinct deformation in appearance. Marking shall be legible.				





